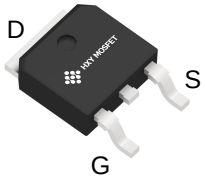
SQD90P04-9M4L_GE3

P-Channel Enhancement Mode MOSFET

Description

The SQD90P04-9M4L_GE3 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

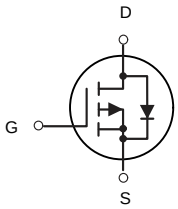


TO-252-2L

General Features

V_{DS} = -40V I_D =-80A

$R_{DS(ON)}$ < 8.2 mΩ@ V_{GS}=10V



P-Channel MOSFET

Application

Battery protection

Load switch

Uninterruptible power supply

Ordering Information

Product ID	Pack	Brand	Qty(PCS)
SQD90P04-9M4L_GE3	TO-252-2L	HXY MOSFET	2500

Absolute Maximum Ratings (T_C=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-40	V
VGS	Gate-Source Voltage	±20	V
I_D@T_C=25°C	Continuous Drain Current, V_{GS} @ 10V[1]	-80	A
I_D@T_C=100°C	Continuous Drain Current, V_{GS} @ 10V[1]	-50	A
IDM	Pulsed Drain Current[2]	-320	A
P_D@T_C=25°C	Total Power Dissipation[4]	81	W
TSTG	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C
$R_{\theta}JA$	Thermal Resistance Junction-ambient [1]	54	°C/W
$R_{\theta}JC$	Thermal Resistance Junction-Case[1]	1.54	°C/W

Electrical Characteristics (T_J=25°C,unless otherwise noted)

Parameter		Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics							
Drain-Source Breakdown Voltage		$V_{(BR)DSS}$	V_{GS} = 0V, I_D = -250μA	-40	-	-	V
Gate-body Leakage current		I_{GSS}	V_{DS} = 0V, V_{GS} = ±20V	-	-	±100	nA
Zero Gate Voltage Drain Current	T_J=25°C	I_{DSS}	V_{DS} = -40V, V_{GS} = 0V	-	-	-1	pA
	T_J=100°C			-	-	-100	
Gate-Threshold Voltage		$V_{GS(th)}$	V_{DS} = V_{GS} , I_D = -250μA	-1.0	-1.6	-2.5	V
Drain-Source on-Resistance[4]		$R_{DS(on)}$	V_{GS} = -10V, I_D = -20A	-	6.4	8.2	mQ
			V_{GS} = -4.5V, I_D = -15A	-	8.2	11	
Forward Transconductance[4]		g_{fs}	V_{DS}= -10V, I_D= -20A	-	104	-	S
Dynamic Characteristics[5]							
Input Capacitance		C_{iss}	V_{DS} = -20V, V_{GS} =0V, f =1MHz	-	5295	-	pF
Output Capacitance		C_{oss}		-	430	-	
Reverse Transfer Capacitance		C_{rss}		-	385	-	
Gate Resistance		R_g	f =1MHz	-	4.3	-	Q
Switching Characteristics[5]							
Total Gate Charge		Q_g	V_{GS} = -10V, V_{DS} = -20V, I_D= -20A	-	110	-	nC
Gate-Source Charge		Q_{gs}		-	12.5	-	
Gate-Drain Charge		Q_{gd}		-	23	-	
Turn-on Delay Time		$t_{d(on)}$	V_{GS} = -10V, V_{DD} = -20V, R_G = 3Ω , I_D= -20A	-	16.8	-	ns
Rise Time		t_r		-	10	-	
Turn-off Delay Time		$t_{d(off)}$		-	65	-	
Fall Time		t_f		-	17	-	
Body Diode Reverse Recovery Time		t_{rr}	I_F = -20A, dI/dt= 100A/μs	-	42	-	ns
Body Diode Reverse Recovery Charge		Q_{rr}		-	29	-	nC
Drain- Source Body Diode Characteristics							
Diode Forward Voltage[4]		V_{SD}	I_S = -20A, V_{GS} = 0V	-	-	-1.2	V
Continuous Source Current	T_C=25°C	I_S	-	-	-	-80	A

Notes:

1. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$=150°C.
2. The EAS data shows Max. rating . The test condition is V_{DD}= -30V, V_{GS}= -10V, L= 0.1mH, I_{AS}= -45A.
3. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
4. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
5. This value is guaranteed by design hence it is not included in the production test.

Typical Characteristics

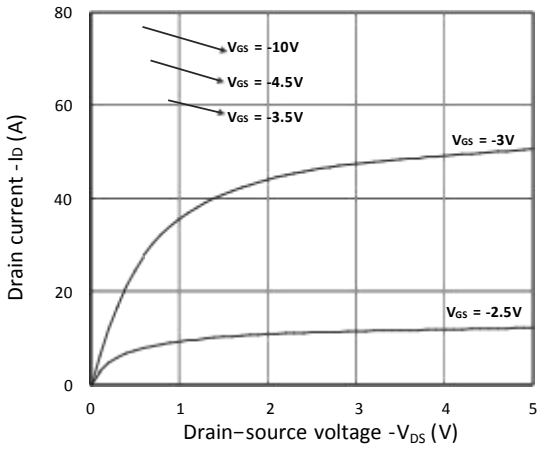


Figure 1. Output Characteristics

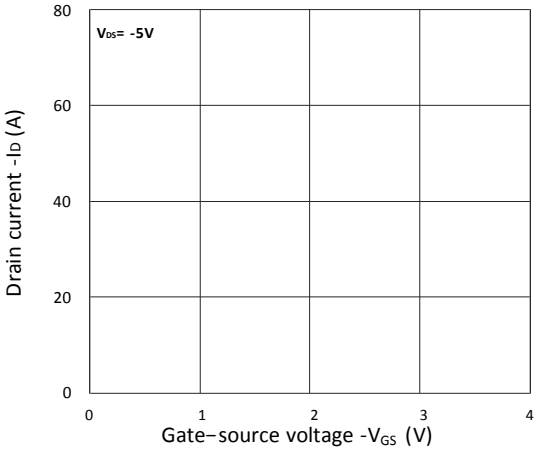


Figure 2. Transfer Characteristics

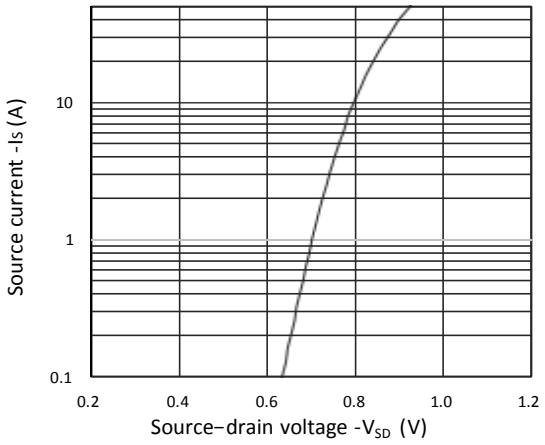


Figure 3. Forward Characteristics of Reverse

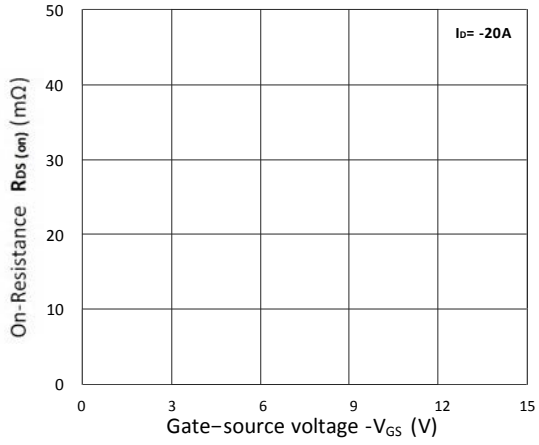


Figure 4. $R_{DS(ON)}$ vs . V_{GS}

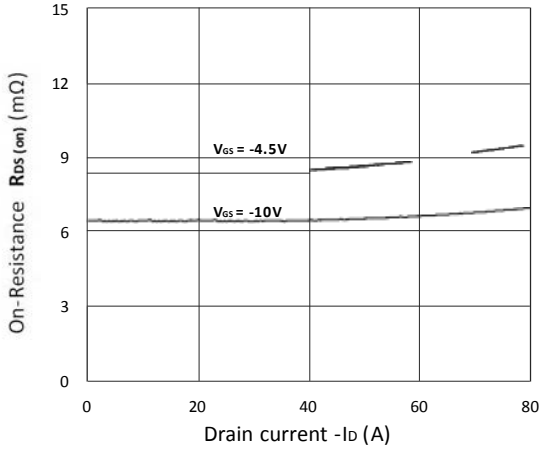


Figure 5. $R_{DS(ON)}$ vs . I_D

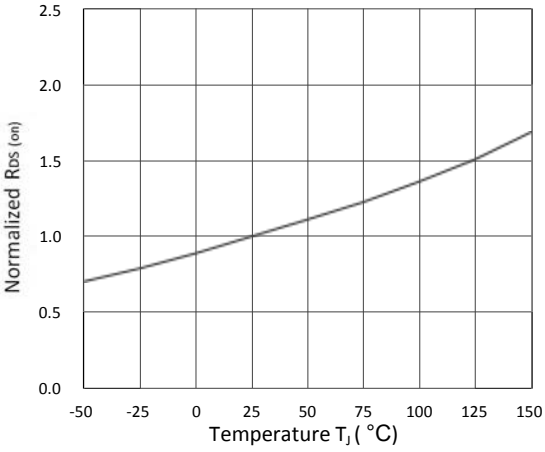


Figure 6. Normalized $R_{DS(on)}$ vs . Temperature

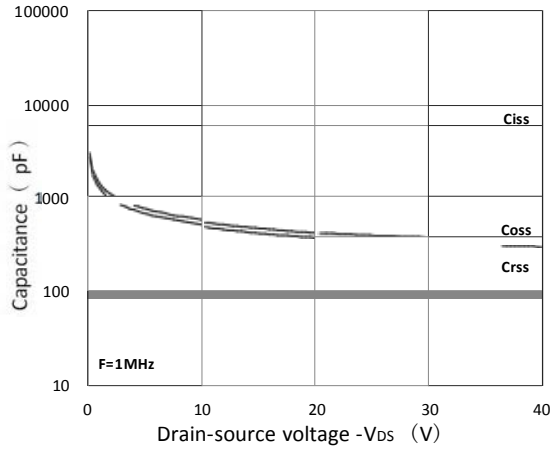


Figure 7. Capacitance Characteristics

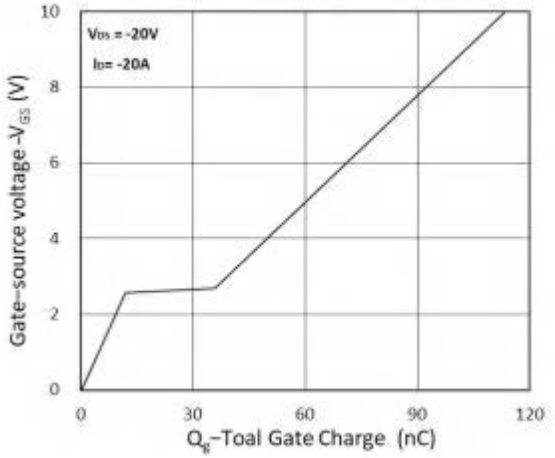


Figure 8. Gate Charge Characteristics

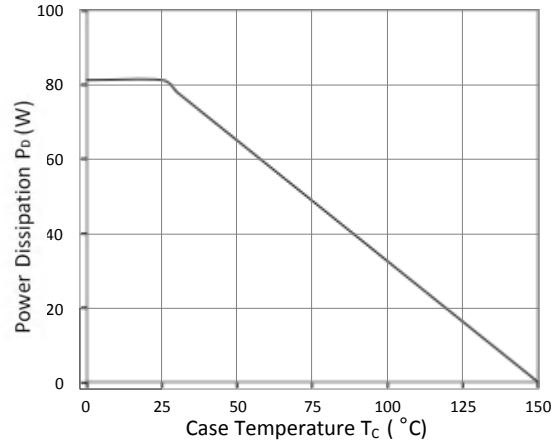


Figure 9. Power Dissipation

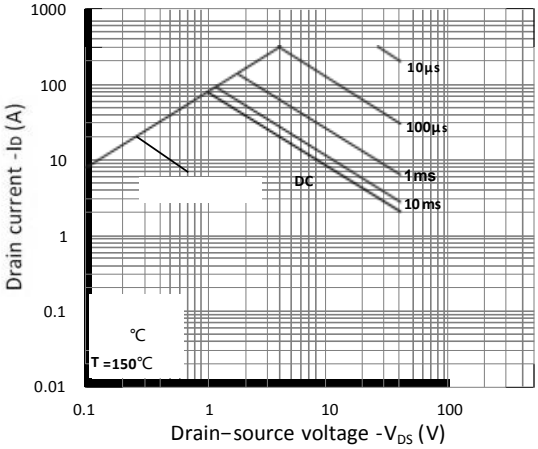


Figure10. Safe Operating Area

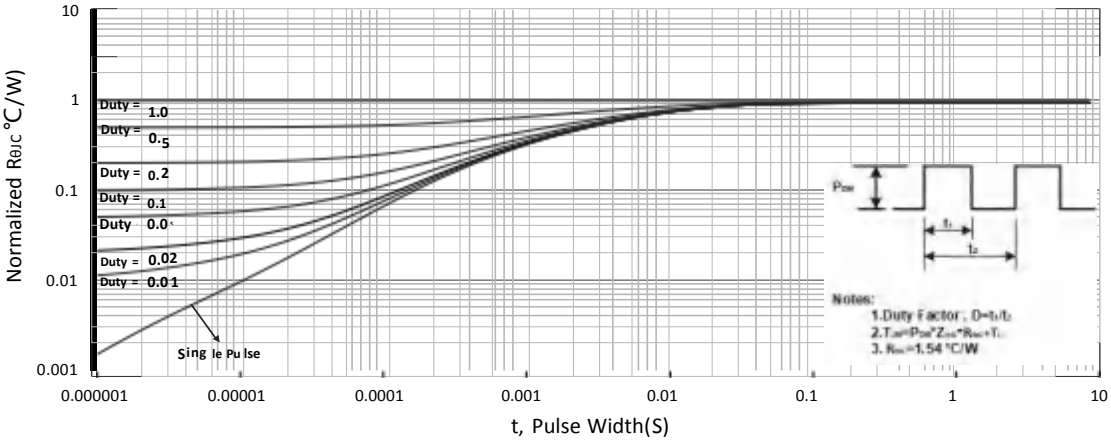


Figure 11. Normalized Maximum Transient Thermal Impedance

Test Circuit

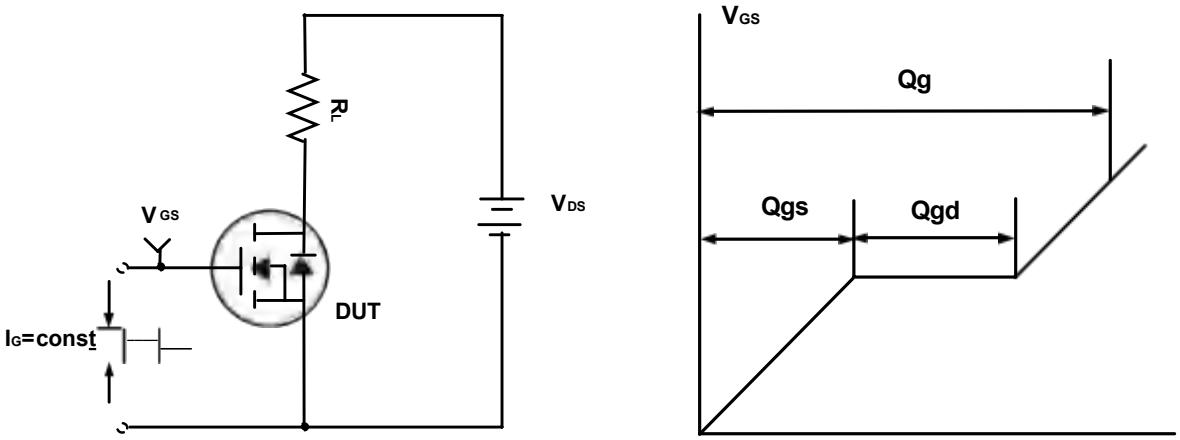


Figure A. Gate Charge Test Circuit & Waveforms

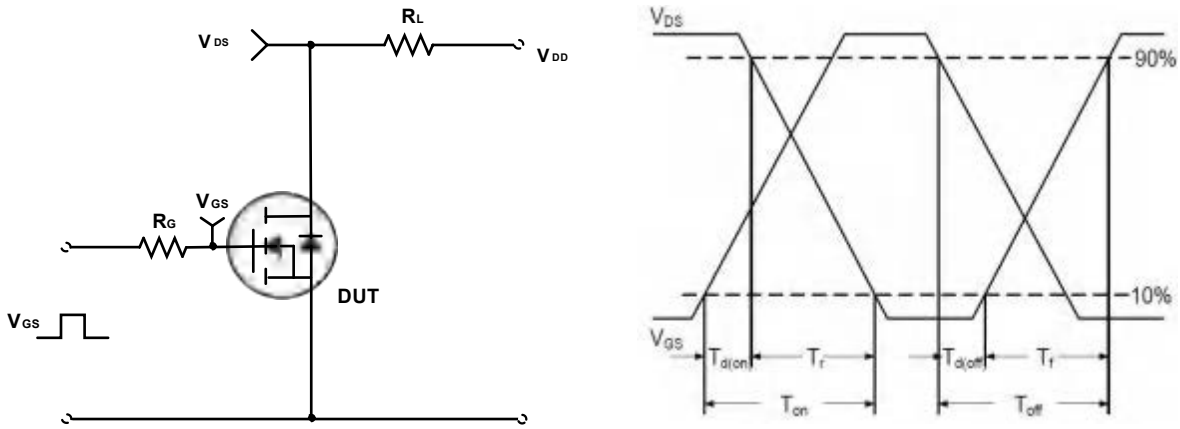


Figure B. Switching Test Circuit & Waveforms

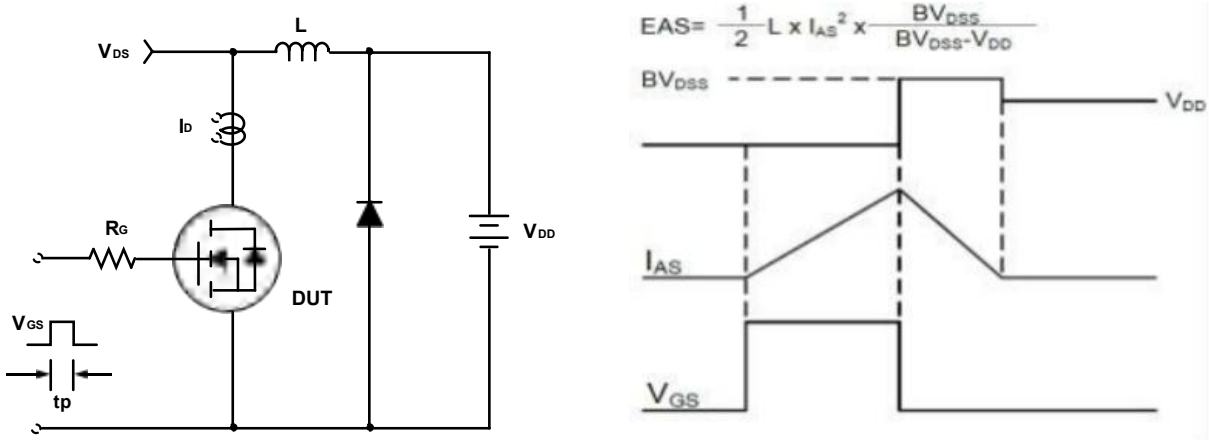
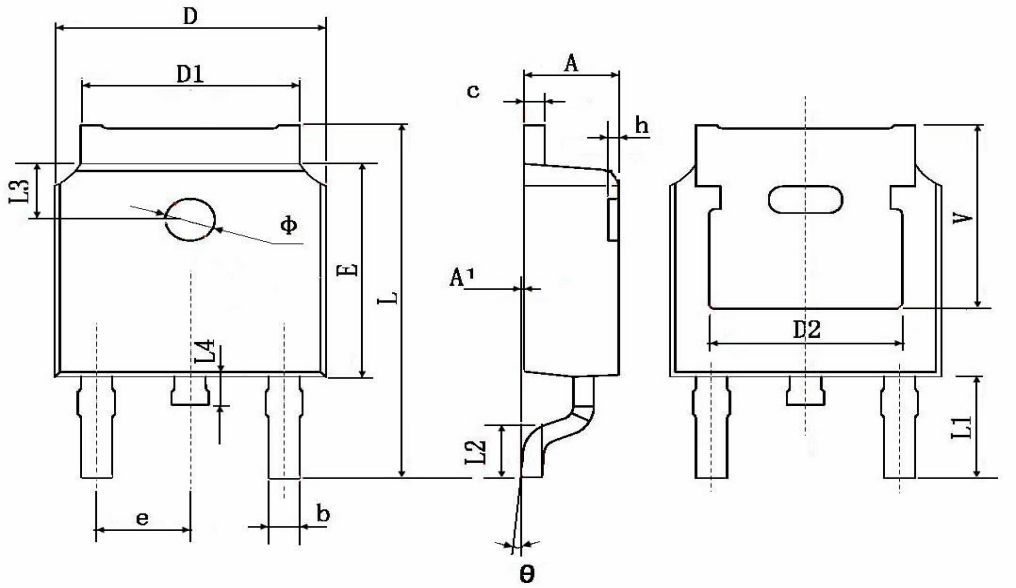


Figure C. Unclamped Inductive Switching Circuit & Waveforms

TO-252-2L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 TYP.		0.190 TYP.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063 TYP.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 TYP.		0.211 TYP.	

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